

# SSM6J505NU

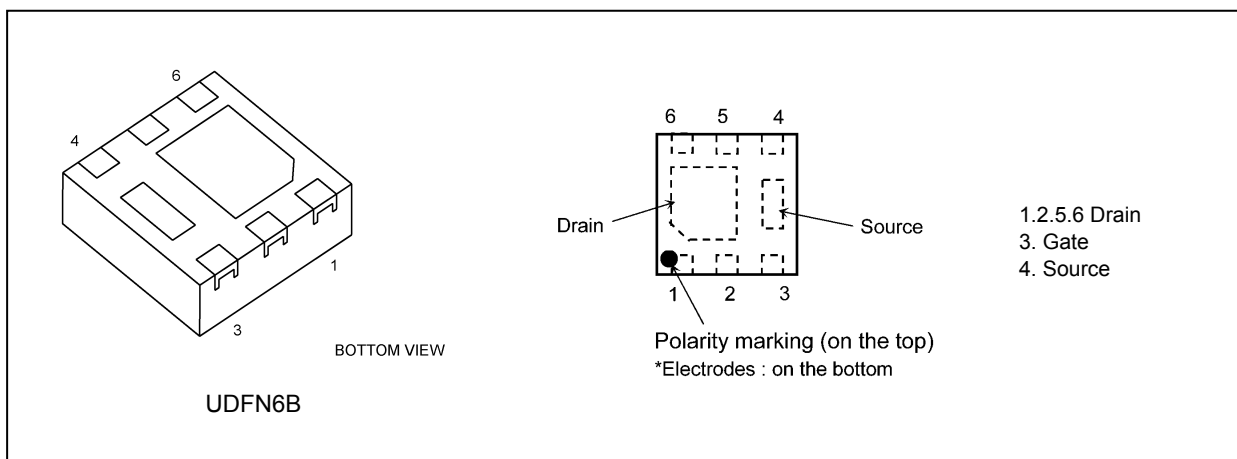
## 1. Applications

- Power Management Switches

## 2. Features

- (1) 1.2 V gate drive voltage.
- (2) Low drain-source on-resistance
  - :  $R_{DS(ON)} = 61 \text{ m}\Omega$  (max) (@ $V_{GS} = -1.2 \text{ V}$ )
  - $R_{DS(ON)} = 30 \text{ m}\Omega$  (max) (@ $V_{GS} = -1.5 \text{ V}$ )
  - $R_{DS(ON)} = 21 \text{ m}\Omega$  (max) (@ $V_{GS} = -1.8 \text{ V}$ )
  - $R_{DS(ON)} = 16 \text{ m}\Omega$  (max) (@ $V_{GS} = -2.5 \text{ V}$ )
  - $R_{DS(ON)} = 12 \text{ m}\Omega$  (max) (@ $V_{GS} = -4.5 \text{ V}$ )

## 3. Packaging and Pin Assignment



**4. Absolute Maximum Ratings (Note) (Unless otherwise specified,  $T_a = 25^\circ\text{C}$ )**

| Characteristics                          | Symbol    | Rating     | Unit             |
|--|-----------|------------|------------------|
| Drain-source voltage                     | $V_{DSS}$ | -12        | V                |
| Gate-source voltage                      | $V_{GSS}$ | $\pm 6$    |                  |
| Drain current (DC) (Note 1)              | $I_D$     | -12        | A                |
| Drain current (pulsed) (Note 1),(Note 2) | $I_{DP}$  | -30        |                  |
| Power dissipation (Note 3)               | $P_D$     | 1.25       | W                |
| Power dissipation $t \leq 10$ s (Note 3) | $P_D$     | 2.5        | W                |
| Channel temperature                      | $T_{ch}$  | 150        | $^\circ\text{C}$ |
| Storage temperature                      | $T_{stg}$ | -55 to 150 |                  |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Ensure that the channel temperature does not exceed  $150^\circ\text{C}$ .

Note 2: Pulse width (PW)  $\leq 10$  ms, duty  $\leq 1\%$

Note 3: Device mounted on a FR4 board.

( $25.4\text{ mm} \times 25.4\text{ mm} \times 1.6\text{ mm}$ , Cu Pad :  $645\text{ mm}^2$ )

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance,  $R_{th(ch-a)}$ , and the drain power dissipation,  $P_D$ , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

**5. Electrical Characteristics**

**5.1. Static Characteristics ( $T_a = 25^\circ\text{C}$  unless otherwise specified)**

| Characteristics                         | Symbol        | Test Condition                                 | Min  | Typ. | Max     | Unit             |
|---|---------------|--|------|------|---------|------------------|
| Gate leakage current                    | $I_{GSS}$     | $V_{GS} = \pm 6\text{ V}, V_{DS} = 0\text{ V}$ | —    | —    | $\pm 1$ | $\mu\text{A}$    |
| Drain cut-off current                   | $I_{DSS}$     | $V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}$   | —    | —    | -1      |                  |
| Drain-source breakdown voltage          | $V_{(BR)DSS}$ | $I_D = -1\text{ mA}, V_{GS} = 0\text{ V}$      | -12  | —    | —       | V                |
| Drain-source breakdown voltage (Note 1) | $V_{(BR)DSX}$ | $I_D = -1\text{ mA}, V_{GS} = 5\text{ V}$      | -7   | —    | —       |                  |
| Gate threshold voltage (Note 2)         | $V_{th}$      | $V_{DS} = -3\text{ V}, I_D = -1\text{ mA}$     | -0.3 | —    | -1.0    |                  |
| Drain-source on-resistance (Note 3)     | $R_{DS(ON)}$  | $I_D = -4.0\text{ A}, V_{GS} = -4.5\text{ V}$  | —    | 9    | 12      | $\text{m}\Omega$ |
|   |               | $I_D = -4.0\text{ A}, V_{GS} = -2.5\text{ V}$  | —    | 11   | 16      |                  |
|   |               | $I_D = -3.5\text{ A}, V_{GS} = -1.8\text{ V}$  | —    | 13   | 21      |                  |
|   |               | $I_D = -1.5\text{ A}, V_{GS} = -1.5\text{ V}$  | —    | 14   | 30      |                  |
|   |               | $I_D = -0.5\text{ A}, V_{GS} = -1.2\text{ V}$  | —    | 18   | 61      |                  |
| Forward transfer admittance (Note 3)    | $ Y_{fs} $    | $V_{DS} = -3\text{ V}, I_D = -2.0\text{ A}$    | 12   | 24   | —       | S                |

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (-1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

Take this into consideration when using the device.

Note 3: Pulse measurement.

**5.2. Dynamic Characteristics ( $T_a = 25^\circ\text{C}$  unless otherwise specified)**

| Characteristics                | Symbol    | Test Condition   | Min | Typ. | Max | Unit        |
|--------------------------------|-----------|--|-----|------|-----|-------------|
| Input capacitance              | $C_{iss}$ | $V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1\text{ MHz}$  | —   | 2700 | —   | $\text{pF}$ |
| Reverse transfer capacitance   | $C_{rss}$ |  | —   | 800  | —   |             |
| Output capacitance             | $C_{oss}$ |  | —   | 800  | —   |             |
| Switching time (turn-on time)  | $t_{on}$  | $V_{DD} = -10\text{ V}, I_D = -1.0\text{ A}$<br>$V_{GS} = 0\text{ to } -2.5\text{ V}, R_G = 4.7\ \Omega,$<br>Duty $\leq 1\%$ , Input: $t_r, t_f < 5\text{ ns}$<br>Ground source, See Chapter 5.3 | —   | 46   | —   | ns          |
| Switching time (turn-off time) | $t_{off}$ |  | —   | 420  | —   |             |

**5.3. Switching Time Test Circuit**

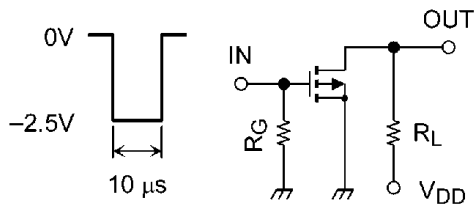


Fig. 5.3.1 Test Circuit of Switching Time

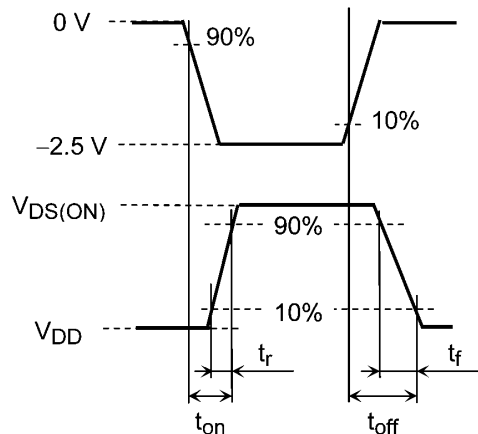


Fig. 5.3.2 Input Waveform/Output Waveform

**5.4. Gate Charge Characteristics ( $T_a = 25^\circ\text{C}$  unless otherwise specified)**

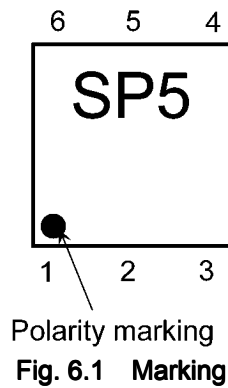
| Characteristics                                 | Symbol    | Test Condition  | Min | Typ. | Max | Unit |
|---|-----------|---|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | $Q_g$     | $V_{DD} = -6\text{ V}, V_{GS} = -4.5\text{ V},$<br>$I_D = -12\text{ A}$ | —   | 37.6 | —   | nC   |
| Gate-source charge 1                            | $Q_{gs1}$ |   | —   | 4.7  | —   |      |
| Gate-drain charge                               | $Q_{gd}$  |   | —   | 8.4  | —   |      |

**5.5. Source-Drain Characteristics ( $T_a = 25^\circ\text{C}$  unless otherwise specified)**

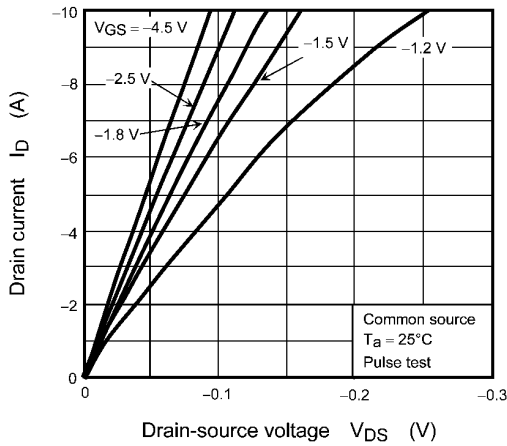
| Characteristics                | Symbol    | Test Condition                            | Min | Typ. | Max | Unit |
|--------------------------------|-----------|---|-----|------|-----|------|
| Diode forward voltage (Note 1) | $V_{DSF}$ | $I_D = 4.0\text{ A}, V_{GS} = 0\text{ V}$ | —   | 0.8  | 1.0 | V    |

Note 1: Pulse measurement.

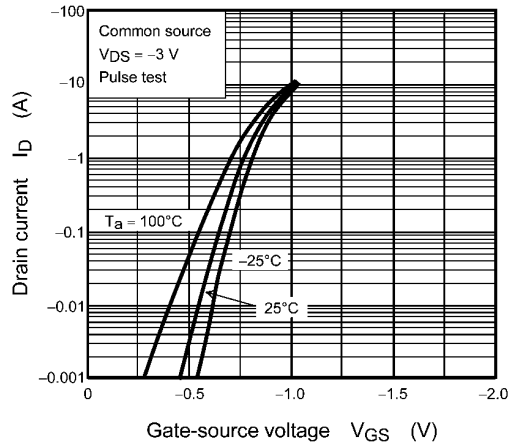
**6. Marking**



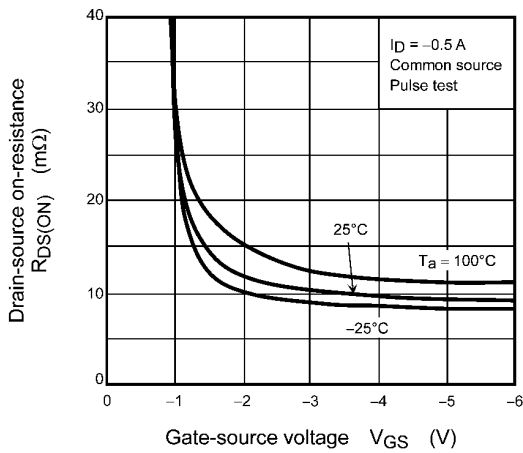
**7. Characteristics Curves (Note)**



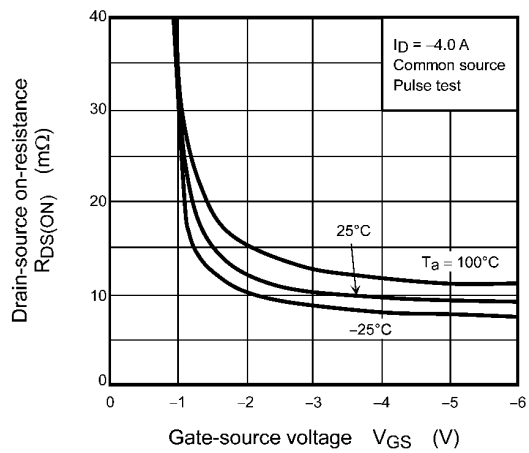
**Fig. 7.1  $I_D - V_{DS}$**



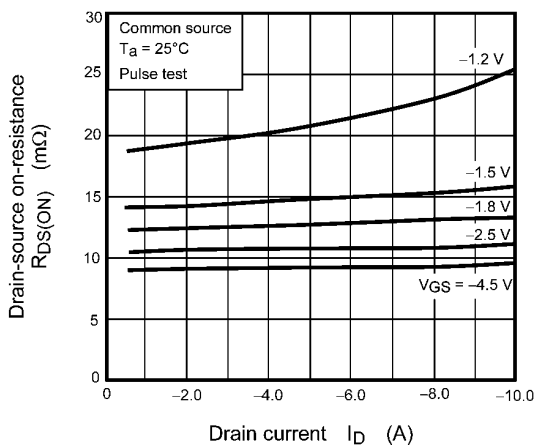
**Fig. 7.2  $I_D - V_{GS}$**



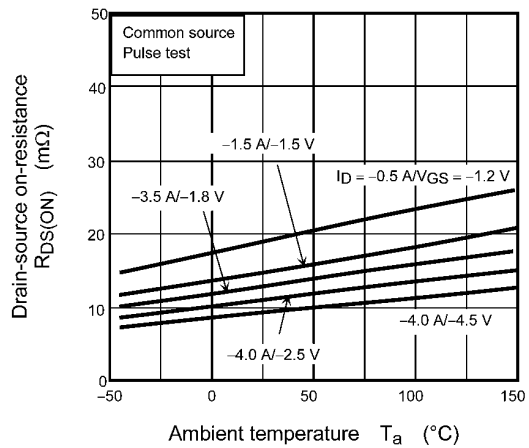
**Fig. 7.3  $R_{DS(ON)} - V_{GS}$**



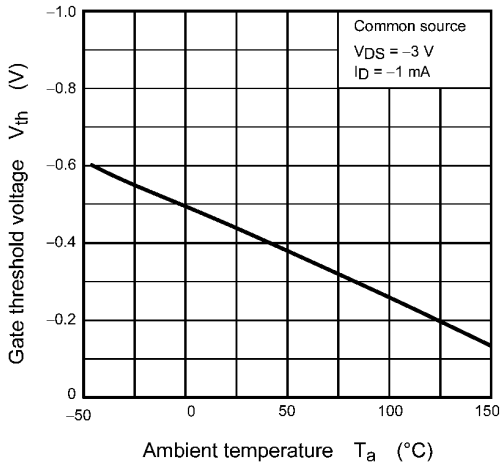
**Fig. 7.4  $R_{DS(ON)} - V_{GS}$**



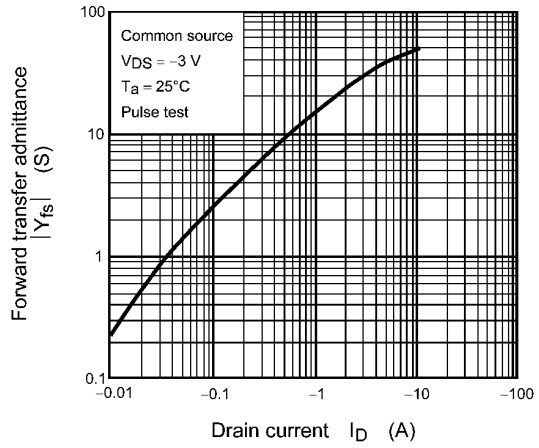
**Fig. 7.5  $R_{DS(ON)} - I_D$**



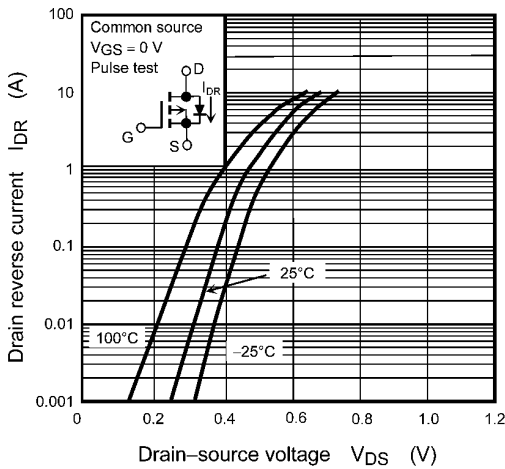
**Fig. 7.6  $R_{DS(ON)} - T_a$**



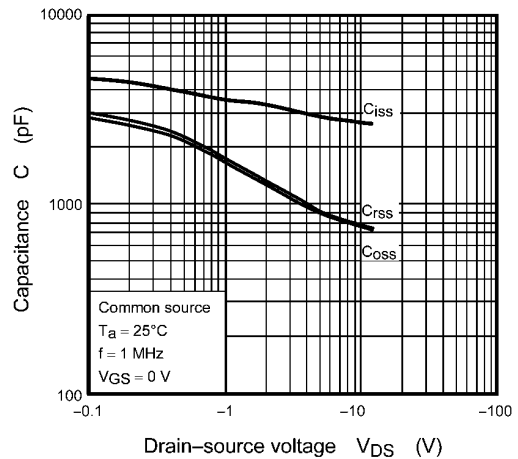
**Fig. 7.7  $V_{th} - T_a$**



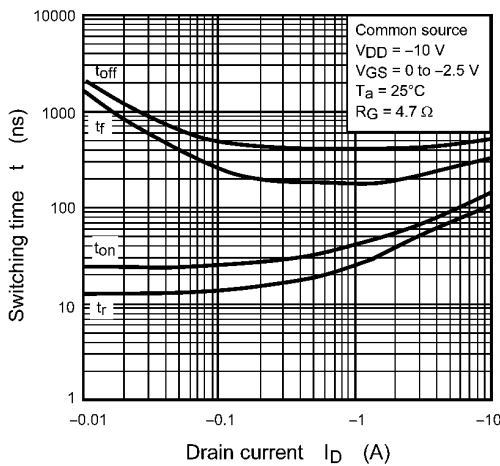
**Fig. 7.8  $|Y_{fs}| - I_D$**



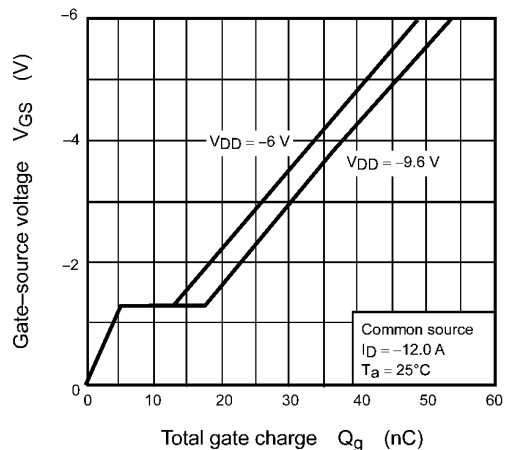
**Fig. 7.9  $I_{DR} - V_{DS}$**



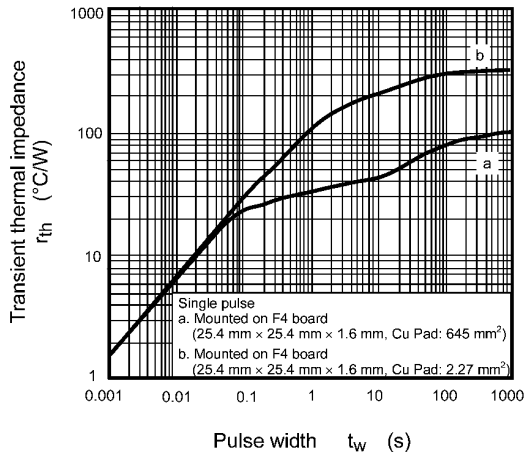
**Fig. 7.10  $C - V_{DS}$**



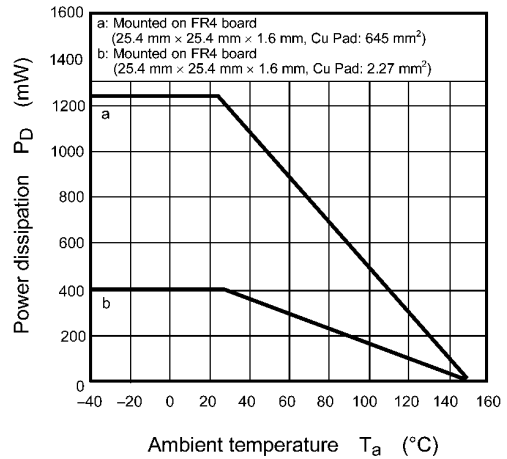
**Fig. 7.11  $t - I_D$**



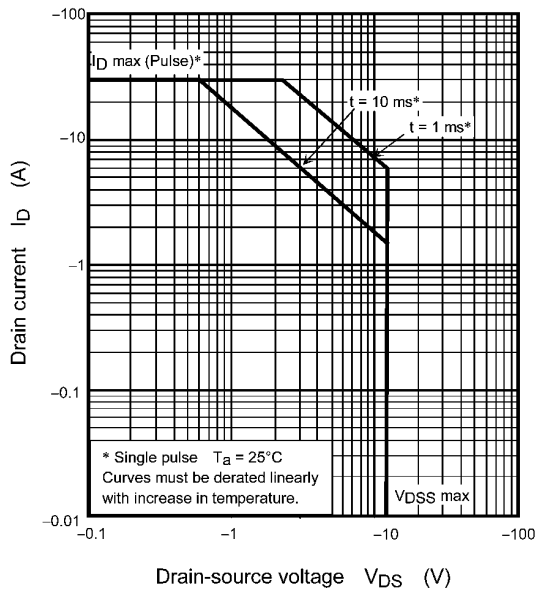
**Fig. 7.12 Dynamic Input/Output Characteristics**



**Fig. 7.13**  $r_{th} - t_w$



**Fig. 7.14**  $P_D - T_a$



**Fig. 7.15** Safe Operating Area

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.





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